Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/065,452	WANG, CHUNG-E
Examiner	Art Unit
Ellen C. Tran	2134

					
SEARCHED					
Class	Subclass	Date	Examiner		
380	269	11/1/2005	ECT		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPTO, USPG, EPO, JPO, DERWENT, IBMTECH DES, INVENTOR	11/1/2005	ECT		